Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination SAFIAN, JOHN W.	
10/751,367		
Examiner	Art Unit	
PHILIPPE S. DERAKSHANI	3754	

SEARCHED					
Class	Subclass	Date	Examiner		
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222	105 209 386.6 481.5	12/21/2005	PD		

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
222/105, 209, 386.5 481.5			
12.00			